INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Not for submission under 37 CFR 1.99)

Application Number		10629302
Filing Date		2003-07-28
First Named Inventor Lewis		B. Aronson
Art Unit		2661
Examiner Name		
Attorney Docket Number		15436.247.2.1.4

kgy	1	XFP MSA Group, Ultra Small, 10-Gigabit Module Slashes Cost, Power and Footprint of Telecommunications and Datacommunications Equipment, Press Release, Irvine, California, 3/4/2002. [World Wide Web page]. Available: www.xfpmsa.org/cgi-bin/pressrelease1.cgi.				
Kon	2	XFP MSA Group New Module to Slash Cost, Power and Size of Telecommunications and Data Communications Equipment, Press Release, Costa Mesa, California, 7/22/2002. [World Wide Web page]. Available: www.xfpmsa.org/cgi-bin/pressrelease3.cgi.				
epm	3	Finisar XFP Achieves 300 m Transmission on Legacy Multlimode Fiber, Finisar News Release, Sunnyvale, California, 9/17/2003. [World Wide Web page]. Available: http://investor.finisar.com/ReleaseDetail.				
KOM	4	XFP MSA Group, About the 10 Gigabit Small Form Factor Pluggable (XFP) Multi Source Agreement (MSA) Group. 2/11/2004. [World Wide Web page]. Available: www.xfpmsa.org/cgi-bin/home.cgi.				
If you wis	h to a	ndd additional non-patent literature document citation inform	nation please click the Add b	utton Add		
		EXAMINER SIGNAT	URE			
Examine	r Sign	ature — ———	Date Considered	6/10/07		
		nitial if reference considered, whether or not citation is in conformance and not considered. Include copy of this for				
Standard S	T.3). ³ cumen	of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. 2 E For Japanese patent documents, the indication of the year of the reign of the appropriate symbols as indicated on the document under WIPO Stranslation is attached.	the Emperor must precede the seri	al number of the patent doc	ument.	

Form PTO-1449

Sheet 1 of 2

Applicant:

Lewis B. Aronson et al.

Serial No.:

10/629,302

July 28, 2003

Confirmation No.: 6438

Att'y Docket No.: 15436.247.2.1.4

Group: 2661

Filing Date: For:

TRANSCEIVER MODULE AND INTEGRATED CIRCUIT WITH DUAL EYE OPENERS

AND BIT ERROR RATE TESTING



INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANT

U.S. Patent Documents

Examiner Initial*	Document Number	Issue <u>Date</u>	Name
Kon 1	5,854,704	12/29/1998	Grandpierre
KOM 2	6,256,127 B1	07/03/2001	Taylor
15M 3	4,932,038	06/05/1990	Windus
BM 4	2002/0021468 A1	02/21/2002	Kato et al.
Kom 5	2002/0060824 A1	05/23/2002	Liou et al.
FOM 6	2003/0053170 A1	03/20/2003	Levinson et al.

Foreign Patent Documents

Examiner
Initial*

Document Number Publication Date

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Other Documents (including author, title, pertinent pages, etc.)

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LXT16706/16707 SerDes Chipset, Intel Products,

www.intel.com/design/network/products/optical/phys/lxt16706.htm, April 19, 2002.

KAM 8

LXT35401 XAUI-to-Quad 3.2G Transceiver, Intel Products,

www.intel.com/design/network/products/optical/phys/lxt35401.htm, April 19, 2002.

Examiner:

Ter Haden

Date Considered:

6/10/07

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO-1449

Applicant: Lewis B. Aronson et al. Serial No.: 10/629,302

For:

Serial No.: 10/629,302 Filing Date: July 28, 2003 Confirmation No.: 6438 Att'y Docket No.: 15436.247.2.1.4 Group: 2661

Sheet 2 of 2

TRANSCEIVER MODULE AND INTEGRATED CIRCUIT WITH DUAL EYE OPENERS

AND BIT ERROR RATE TESTING

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National Semiconductor DS92LV16 Design Guide, Serializing Made Simple, February 2002.

12 Vaishali Semiconductor, Fibre Channel Transceiver, VN16117, MDSN-0002-02, 08/09/2001.

Fairchild Semiconductor, Application Note 77, CMOS, the Ideal Logic Family, January 1983.

Analog Target Specification, Annex 48B, Published by IEEE New York, 05/2001, pp. 6-14.

References Cited by Applicants

While the filing of Information Disclosure Statements is voluntary, the procedure is governed by the guidelines of Section 609 of the Manual of Patent Examining Procedure and 37 C.F.R. §§ 1.97 and 1.98. To be considered a proper Information Disclosure Statement, Form PTO-1449 shall be accompanied by a copy of each listed patent or publication or other item of information and a translation of the pertinent portions of foreign documents (if an existing translation is readily available to the applicant), an explanation of relevance of each reference not in the English language, and should be submitted in a timely manner as set out in MPEP Sec. 609.

Examiners will consider all citations submitted in conformance with 37 C.F.R. § 1.98 and MPEP Sec. 609 and place their initials adjacent the citations in the spaces provided on this form. Examiners will also initial citations not in conformance with the guidelines which may have been considered. A reference may be considered by the Examiner for any reason whether or not the citation is in full conformance with the guidelines. A line will be drawn through a citation if it is not in conformance with the guidelines AND has not been considered. A copy of the submitted form, as reviewed by the Examiner, will be returned to the applicant with the next communication. The original of the form will be entered into the application file.

Each citation initialed by the Examiner will be printed on the issued patent in the same manner as references cited by the Examiner on Form PTO-892.

The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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Examiner: Date Considered:

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